## PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Takahiro KASUGA et al.

Appln. No.:

Filed: Herewith

For: A SEMICONDUCTOR DEVICE AND A METHOD OF MANUFACTURING THE SAME

\* \* \*

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Without any assertion of materiality or prior art effect, Applicants wish to make record the documents cited in predecessor Application Nos. 10/123,242 filed April 17, 2002 and 09/920,942 filed August 3, 2001, whether cited by Applicants or by the Patent Office. The documents are listed on the attached Form-1449 as Documents AA-AM on sheet 1.

Applicants also wish to make of record Documents AA\*-AD\* (copies provided herewith) which were cited in related Application No. 10/325,908 filed December 23, 2002.

Respectfully submitted,

MWS: jab

Miles & Stockbridge P.C. 1751 Pinnacle Drive, Suite 500 McLean, Virginia 22102-3833 (703) 903-9000

July 25, 2003

Y: Mitchell W. Shar

Reg. No. 31,568

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		FORM PTO	-1449	Atty. Docket	NO.	App	Appln. No.	
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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